

What is claimed is:

1. A transfer mechanism for transferring substrates to be processed with respect to a processing apparatus in a semiconductor processing system, the transfer mechanism comprising:

a transfer base;

a support for supporting the transfer base; and

a first and a second support arm disposed on the transfer base,

wherein the support includes a stretchable and bendable arm that is stretchable and bendable, and

wherein the first and the second support arm respectively have a first and a second support surface for holding the substrates to be processed; the first and the second support surface are positioned on a substantially same plane; and the first and the second support arm are operated such that the first and the second support surface are projected from the transfer base toward a substantially equivalent side.

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4. The transfer mechanism of claim 1, wherein a first and

a second driving motor for respectively sliding the first and the second support arm and a third driving motor for revolving the transfer base are disposed at an outside of the transfer base, and an axis for revolving the transfer base with respect to the support has a three-axis coaxial structure for transferring driving forces of the first to the third driving motors.

5. (Amended) A transfer mechanism for transferring substrates to be processed with respect to a processing apparatus in a semiconductor processing system, the transfer mechanism comprising:

- a transfer chamber air-tightly formed by a case;
- a sectional plate disposed in the transfer chamber to form a first and a second space therein;
- a transfer base disposed in the first space;
- a moving table, disposed in the second space, for linearly moving the transfer base;
- a guide rail, disposed in the second space, for guiding the moving table along a length direction of the guide rail;
- a driving mechanism for moving the moving table along the guide rail;
- a gas exhaust port, formed at a bottom portion of the second space, for evacuating an internal atmosphere of the second space; and

a first and a second support arm disposed on the transfer base,

wherein the first and the second support arm respectively have a first and a second support surface for holding the substrates to be processed; the first and the second support surface are positioned on a substantially same plane; and the first and the second support arm are operated such that the first and the second support surface are projected from the transfer base toward a substantially equivalent side.

6. (Canceled)

7. The transfer mechanism of claim 6, wherein the first and the second chamber are surrounded by a case; a first and a second driving motor for respectively sliding the first and the second support arm and a third driving motor for revolving the transfer base are disposed at an outside of the case; and the transfer base is connected with the moving body by the coupling axis having a three-axis coaxial structure for transferring driving forces of the first to the third driving motors.

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9. (Amended) A transfer mechanism for transferring substrates to be processed relative to a processing apparatus in a semiconductor processing system, the transfer mechanism comprising:

5 a transfer base; and

 a first and a second support arm disposed on the transfer base,

 wherein the first and the second support arm respectively have a first and a second support surface for holding the substrates to be processed; the first and the second support surface are positioned on a substantially same plane; the first and the second support arm are operated such that the first and the second support surface are projected from the transfer base toward a substantially equivalent side; and the first and the second support surface slide along substantially circular arcs.

10. (Amended) The transfer mechanism of claim 1, wherein the first and the second support surface slide along substantially circular arcs, and the first and the second support surface occupy a same position when being in a state projected from the transfer base.

11. (Amended) The transfer mechanism of claim 1 or 5, wherein the first and the second support surface slide along directions converging toward each other when projected from

the transfer base.

12.(Amended) The transfer mechanism of claim 1, wherein the first and the second support arm slide along directions
5 converging toward each other when projected from the transfer base, and the first and the second support surface occupy a same position when being in a state projected from the transfer base.

10 13.(Amended) The transfer mechanism of claim 1 or 5, wherein the first and the second support surface slide along directions diverging from each other when projected from the transfer base.

15 14.(Canceled)

15.(Canceled)

16.(Canceled)

20 17.(Amended) A semiconductor processing system comprising:

a common transfer chamber;

a plurality of processing apparatuses connected in parallel to the common transfer chamber; and

25 a transfer mechanism, disposed in the common transfer chamber, for transferring substrates to be processed

relative to the processing apparatuses,

wherein the transfer mechanism includes:

a transfer base;

a support for supporting the transfer base; and

5 a first and a second support arm disposed on the transfer base,

wherein the support includes a stretchable and bendable arm that is stretchable and bendable, and

wherein the first and the second support arm
10 respectively have a first and a second support surface for holding the substrates to be processed; the first and the second support surface are positioned on a substantially same plane; and the first and the second support arm are operated such that the first and the second support surface
15 are projected from the transfer base toward a substantially equivalent side.

18. The semiconductor processing system of claim 17, further comprising an evacuable load-lock chamber connected
20 in parallel with the processing apparatuses to the common transfer chamber, which is also evacuable.

19. (Amended) The semiconductor processing system of claim 17, wherein the first and the second support surface slide along
25 substantially circular arcs, and the first and the second support surface occupy a same position when being in a state

projected from the transfer base.

20. (Amended) The semiconductor processing system of claim 17,
wherein the first and the second support surface slide along
5 directions converging toward each other when projected from
the transfer base, and the first and the second support
surface occupy a same position when being in a state
projected from the transfer base.

10 21. (Amended) The semiconductor processing system of claim 17,
wherein the first and the second support surface slide along
directions diverging from each other when projected from the
transfer base.

15 22. (Canceled)

23. (Amended) The semiconductor processing system of claim 17,
further comprising a controller for controlling the transfer
mechanism to simultaneously revolve the transfer base and
20 slide at least one of the first and the second support arm.

24. (Amended) The semiconductor processing system of claim 17,
wherein the transfer base is linearly movable and
the semiconductor processing system further comprising
25 a controller for controlling the transfer mechanism to
simultaneously make a linear motion of the transfer base and

operate at least one of the first and the second support arm.

25. (New) A transfer mechanism for transferring substrates to be processed relative to a processing apparatus in a semiconductor processing system, the transfer mechanism comprising:

a multi-joint arm;

a first and a second support arm disposed at a leading end of the multi-joint arm; and

10 driving motors, disposed on the multi-joint arm, for driving the first and the second support arm,

wherein the first and the second support arm respectively have a first and a second support surface for holding the substrates to be processed; the first and the second support surface are positioned on a substantially same plane; and the first and the second support arm are operated such that the first and the second support surface are projected from the transfer base toward a substantially equivalent side.

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26. (New) A semiconductor processing system comprising:

a common transfer chamber;

a plurality of processing apparatuses connected in parallel to the common transfer chamber; and

25 a transfer mechanism, disposed in the common transfer chamber, for transferring substrates to be processed

relative to the processing apparatuses,
wherein the transfer mechanism includes:
a multi-joint arm;
a first and a second support arm disposed at a leading
5 end of the multi-joint arm; and
driving motors, disposed on the multi-joint arm, for
driving the first and the second support arm,
wherein the first and the second support arm
respectively have a first and a second support surface for
10 holding the substrates to be processed; the first and the
second support surface are positioned on a substantially
same plane; and the first and the second support arm are
operated such that the first and the second support surface
are projected from the transfer base toward a substantially
15 equivalent side.

27.(New) A transfer mechanism for transferring substrates to be processed with respect to a processing apparatus in a semiconductor processing system, the transfer mechanism comprising:

5 a transfer base;
 a support for revolvably supporting the transfer base;
 a first and a second support arm disposed on the transfer base; and
 a driving unit, disposed on the transfer base, for
10 driving the first and the second support arm,
 wherein the first and the second support arm respectively have a first and a second support surface for holding the substrates to be processed; the first and the second support surface are positioned on a substantially
15 same plane; and the first and the second support arm are operated such that the first and the second support surface are projected from the transfer base toward a substantially equivalent side.

20 28.(New) The transfer mechanism of claim 27, wherein the transfer base is linearly movable and
 the transfer mechanism further comprising a controller for controlling the transfer mechanism to simultaneously make a linear motion of the transfer base and operate at
25 least one of the first and the second support arm.

29.(New) A semiconductor processing system comprising:
a common transfer chamber;
a plurality of processing apparatuses connected in parallel to the common transfer chamber; and
5 a transfer mechanism, disposed in the common transfer chamber, for transferring substrates to be processed with respect to the processing apparatuses,
wherein the transfer mechanism includes:
a transfer base;
10 a support for revolvably supporting the transfer base;
a first and a second support arm disposed on the transfer base; and
a driving unit, disposed on the transfer base, for driving the first and the second support arm,
15 wherein the first and the second support arm respectively have a first and a second support surface for holding the substrates to be processed; the first and the second support surface are positioned on a substantially same plane; and the first and the second support arm are
20 operated such that the first and the second support surface are projected from the transfer base toward a substantially equivalent side.

30.(New) The semiconductor processing system of claim 29,
25 further comprising evacuable load-lock chambers connected in parallel with the processing apparatuses to the common

transfer chamber, which is also evacuable.

31.(New) The semiconductor processing system of claim 29,
wherein the first and the second support surface slide along
5 substantially circular arcs, and the first and the second
support surface occupy a same position when being in a state
projected from the transfer base.

32.(New) The semiconductor processing system of claim 29,
10 wherein the first and the second support surface slide along
directions converging toward each other when projected from
the transfer base, and the first and the second support
surface occupy a same position when being in a state
projected from the transfer base.

15 33.(New) The semiconductor processing system of claim 29,
wherein the first and the second support surface slide along
directions diverging from each other when projected from the
transfer base.

20 34.(New) The semiconductor processing system of claim 29,
further comprising a controller for controlling the transfer
mechanism to simultaneously revolve the transfer base and
slide at least one of the first and the second support arm.

25 35.(New) The semiconductor processing system of claim 29,

wherein the transfer base is linearly movable and
the semiconductor processing system further comprising
a controller for controlling the transfer mechanism to
simultaneously make a linear motion of the transfer base and
5 operate at least one of the first and the second support arm.

36.(New) The semiconductor processing system of claim 30,
further comprising a controller for controlling the transfer
mechanism to simultaneously unload two substrates to be
10 processed from the load-lock chambers and simultaneously
transfer and mount the two unloaded substrates to be
processed onto two of the processing apparatuses.